Search Notes



Application/Control No

10565406

Applicant(s)/Patent Under Reexamination

BAIK ET AL.

Examiner

Lorna M Douyon

Art Unit

1796

SEARCHED

Class	Subclass	Date	Examiner
510	443, 452, 509, 511		LMD

SEARCH NOTES	

Search Notes	Date	Examiner
EAST	9/24/08	LMD

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/Lorna M Douyon/ Primary Examiner.Art Unit 1796

U.S. Patent and Trademark Office Part of Paper No.: 20080927